Notice of References Cited Application/Control No. 10/549,696 Examiner John Freeman Applicant(s)/Patent Under Reexamination TAKENAKA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,556,931 A	09-1996	Imura et al.	526/323.1
*	В	US-6,034,193 A	03-2000	Henry et al.	526/222
*	С	US-6,802,993 B2	10-2004	Momoda et al.	252/586
*	D	US-6,913,357 B2	07-2005	Kadowaki, Shinichiro	351/177
*	E	US-2005/0263745 A1	12-2005	Momoda et al.	252/586
*	F	US-7,087,195 B2	08-2006	Kawasaki, Takayoshi	252/586
*	G	US-3,713,869	01-1973	Geffcken et al.	427/489
*	Н	US-5,963,373	10-1999	Kayanoki, Hisayuki	359/581
*	1	US-6,391,433	05-2002	Jiang et al.	428/220
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1130038 A1	09-2001	European Patent	MOMODA et al.	C08F220/10
	0		,			
	Р					
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	R					
	s	·				
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	w						
	×						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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